onsemi

NXH400N100H4Q2F2PG, NXH400N100H4Q2F2SG, NXH400N100H4Q2F2SG-R

This high-denity, integrated power module combines high-performance IGBTs with rugged anti-parallel diodes.

Features

- Extremely Efficient Trench with Field Stop Technology
- Low Switching Loss Reduces System Power Dissipation
- Module Design Offers High Power Density
- Low Inductive Layout
- Low Package Height
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Solar Inverters
- Uninterruptable Power Supplies Systems

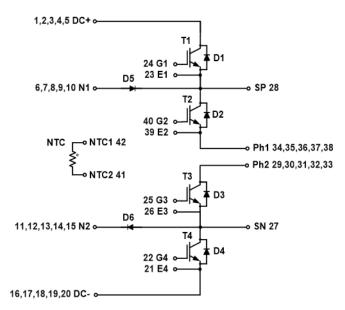
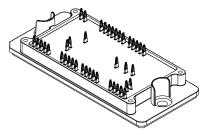
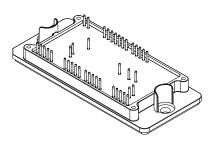


Figure 1. NXH400N100H4Q2F2PG/SG/SG–R Schematic Diagram

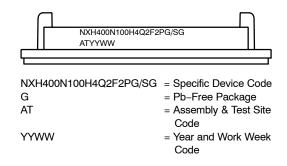


Q2PACK INPC PRESS FIT PINS PIM42, 93x47 (PRESSFIT) CASE 180BH



Q2PACK INPC SOLDER PINS PIM44, 93x47 (SOLDER PIN) CASE 180BS

MARKING DIAGRAM



PIN CONNECTIONS

See details pin connections on page 2 of this data sheet.

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

PIN CONNECTIONS

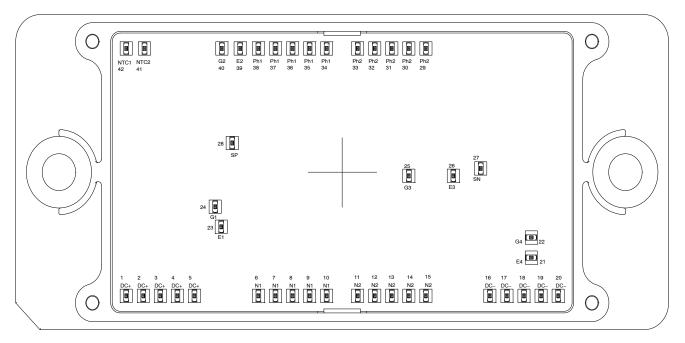


Figure 2. Pin Connections

ABSOLUTE MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Rating	Symbol	Value	Unit
OUTER IGBT (T1, T4)			
Collector-Emitter Voltage	V _{CES}	1000	V
Gate-Emitter Voltage Positive Transient Gate–Emitter Voltage (T _{pulse} = 5 μs, D < 0.10)	V _{GE}	±20 30	V
Continuous Collector Current @ T _C = 80°C	Ι _C	409	А
Pulsed Peak Collector Current @ T_C = 80°C (T_J = 150°C)	I _{C(Pulse)}	1227	А
Maximum Power Dissipation (T _J = 150°C)	P _{tot}	959	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	175	°C
INNER IGBT (T2, T3)			
Collector-Emitter Voltage	V _{CES}	1000	V
Gate-Emitter Voltage Positive Transient Gate–Emitter Voltage (T _{pulse} = 5 μs, D < 0.10)	V _{GE}	±20 30	V
Continuous Collector Current @ $T_C = 80^{\circ}C$	Ι _C	360	А
Pulsed Peak Collector Current @ T_C = 80°C (T_J = 150°C)	I _{C(Pulse)}	1080	А
Maximum Power Dissipation (T _J = 175°C)	P _{tot}	805	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	175	°C
IGBT INVERSE DIODE (D1, D2, D3, D4)			
Peak Repetitive Reverse Voltage	V _{RRM}	1000	V
Continuous Forward Current @ T _C = 80°C	١ _F	192	А
Repetitive Peak Forward Current (T _J = 175°C)	I _{FRM}	576	А

ABSOLUTE MAXIMUM RATINGS (T, I = 25°C unless otherwise noted) (continued)

Rating	Symbol	Value	Unit
IGBT INVERSE DIODE (D1, D2, D3, D4)			
Maximum Power Dissipation ($T_J = 175^{\circ}C$)	P _{tot}	482	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	175	°C
NEUTRAL POINT DIODE (D5, D6)			
Peak Repetitive Reverse Voltage	V _{RRM}	1200	V
Continuous Forward Current @ $T_C = 80^{\circ}C$	١ _F	140	А
Repetitive Peak Forward Current ($T_J = 175^{\circ}C$)	IFRM	420	А
Maximum Power Dissipation ($T_J = 175^{\circ}C$)	P _{tot}	401	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Refer to ELECTRICAL CHARACTERISTICS and/or APPLICATION INFORMATION for Safe Operating parameters.

THERMAL AND INSULATION PROPERTIES (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
THERMAL PROPERTIES			
Operating Temperature under Switching Condition	T _{VJOP}	-40 to 150	°C
Storage Temperature Range	T _{stg}	-40 to 125	°C
INSULATION PROPERTIES			
Isolation Test Voltage, t = 2 s, 50 Hz (Note 3)	V _{is}	4000	V _{RMS}
Creepage Distance		12.7	mm

Comparative Tracking Index	CTI	>600		
Stresses exceeding those listed in the Maximum Ratings table may damage th	e device. If any of	these limits are exceeded, device	functionality	

should not be assumed, damage may occur and reliability may be affected. Refer to <u>ELECTRICAL CHARACTERISTICS</u> and/or APPLICATION INFORMATION for Safe Operating parameters.
 4000 VAC_{RMS} for 1 second duration is equivalent to 3333 VAC_{RMS} for 1 minute duration.

Characteristic	Test Conditions	Symbol	Min	Тур	Max	Unit
OUTER IGBT (T1, T4) CHARACTER	STICS			•		
Collector-Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 1000 V	I _{CES}	-	-	500	μA
Collector-Emitter Saturation Voltage	V _{GE} = 15 V, I _C = 400 A, T _J = 25°C	V _{CE(sat)}	_	1.77	2.3	V
	V _{GE} = 15 V, I _C = 400 A, T _J = 150°C	. ,	-	2.11	_	
Gate-Emitter Threshold Voltage	V _{GE} = V _{CE} , I _C = 400 mA	V _{GE(TH)}	4.1	5.1	6.1	V
Gate Leakage Current	$V_{GE} = \pm 20$ V, $V_{CE} = 0$ V	I _{GES}	-	-	±2000	nA
Internal Gate Resistor		R _G	_	1.44	_	Ω
Turn-on Delay Time	T _J = 25°C	t _{d(on)}	_	151	_	ns
Rise Time	V _{CE} = 600 V, I _C = 150 A V _{GE} = -8 V, 15 V, R _{Gon} = 6 Ω,	t _r	_	35	_	
Turn-off Delay Time	$R_{Goff} = 11 \Omega$	t _{d(off)}	_	551	_	
Fall Time	1	t _f	_	68	_	
Turn-on Switching Loss per Pulse	1	E _{on}	_	3270	_	μJ
Turn-off Switching Loss per Pulse	1	E _{off}	-	5100	_	
Turn-on Delay Time	T _{.1} = 125°C	t _{d(on)}	_	146	_	ns
Rise Time	V _{CE} = 600 V, I _C = 150 A V _{GE} = –8 V, 15 V, R _{Gon} = 6 Ω,	t _r	_	40	_	
Turn-off Delay Time	$V_{GE} = -8 V$, 15 V, $N_{Gon} = 0 \Omega_2$, $R_{Goff} = 11 \Omega$	t _{d(off)}	_	626	_	
Fall Time	1	t _f	_	88	_	
Turn-on Switching Loss per Pulse	1	E _{on}	_	4165	_	μJ
Turn-off Switching Loss per Pulse	-	E _{off}	_	8420	_	
Input Capacitance	V _{CE} = 20 V, V _{GE} = 0 V, f = 1 MHz	C _{ies}	_	26093	_	pF
Output Capacitance		C _{oes}	_	1012	_	
Reverse Transfer Capacitance		C _{res}	_	104	_	
Total Gate Charge	V _{CE} = 600 V, I _C = 300 A, V _{GE} = −15 V~15 V	Qg	—	1304	_	nC
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	R _{thJH}	_	0.181	_	K/W
Thermal Resistance – Chip-to-Case	λ = 2.9 W/mK	R _{thJC}	_	0.073	_	K/W
NEUTRAL POINT DIODE (D5, D6) C	HARACTERISTICS				1	4
Diode Forward Voltage	I _F = 100 A, T _J = 25°C	V _F	_	1.50	1.85	V
	I _F = 100 A, T _J = 150°C	1	_	2.07	_	
Reverse Recovery Time	T _J = 25°C	t _{rr}	_	19	_	ns
Reverse Recovery Charge	V _{CE} = 600 V, I _C = 150 A V _{GE} = –8 V, 15 V, R _G = 6 Ω	Q _{rr}	_	229	_	nC
Peak Reverse Recovery Current	$V_{GE} = -0.0, 10.0, 100, 100 = 0.22$	I _{RRM}	_	19	_	Α
Peak Rate of Fall of Recovery Current		di/dt	-	6053	-	A/µs
Reverse Recovery Energy	1	E _{rr}	_	164	_	μJ
Reverse Recovery Time	T _J = 125°C	t _{rr}	_	34	_	ns
Reverse Recovery Charge	V _{CE} = 600 V, I _C = 150 A V _{GE} = –8 V, 15 V, R _G = 6 Ω	Q _{rr}	_	359	-	nC
Peak Reverse Recovery Current		I _{RRM}	_	17	_	А
Peak Rate of Fall of Recovery Current	1	di/dt	-	4621	-	A/μs
Reverse Recovery Energy	1	Err	-	211	-	μJ
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	R _{thJH}	_	0.364	_	K/W
Thermal Resistance - Chip-to-Case	λ = 2.9 W/mK	R _{thJC}	_	0.237	_	K/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Characteristic **Test Conditions** Symbol Min Тур Max Unit **INNER IGBT (T2, T3) CHARACTERISTICS** Collector-Emitter Cutoff Current V_{GE} = 0 V, V_{CE} = 1000 V ICES _ _ 500 μΑ Collector-Emitter Saturation Voltage $V_{GE} = 15 \text{ V}, I_{C} = 400 \text{ A}, T_{J} = 25^{\circ}\text{C}$ V_{CE(sat)} V 1.77 2.3 _ V_{GE} = 15 V, I_C = 400 A, T_J = 150°C 2.11 Gate-Emitter Threshold Voltage $V_{GE} = V_{CE}$, $I_C = 400 \text{ mA}$ V_{GE(TH)} 5.1 6.1 V 4.1 V_{GE} = ±20 V, V_{CE} = 0 V ±2000 Gate Leakage Current IGES _ _ nA Internal Gate Resistor R_{G} 1.44 Ω _ Turn-on Delay Time T_J = 25°C t_{d(on)} 149 ns $V_{CE} = 600 \text{ V}, \text{ I}_{C} = 150 \text{ A}$ 37 **Rise Time** tr _ _ $V_{GE}^{2} = -8 V$, 15 V, $R_{Gon} = 6 \Omega$, $R_{Goff} = 23 \Omega$ Turn-off Delay Time t_{d(off)} _ 882 _ t_f Fall Time 35 _ _ Turn-on Switching Loss per Pulse Eon 4970 μJ Turn-off Switching Loss per Pulse 6010 Eoff _ _ T_J = 125°C Turn-on Delay Time 146 _ _ ns t_{d(on)} $V_{CE} = 600 \text{ V}, I_{C} = 150 \text{ A}$ **Rise Time** tr 42 $V_{GE} = -8 V$, 15 V, $R_{Gon} = 6 \Omega$, $R_{Goff} = 23 \Omega$ Turn-off Delay Time 977 _ t_{d(off)} _ Fall Time t_f _ 12 _ Turn-on Switching Loss per Pulse E_{on} 7790 μJ _ Turn-off Switching Loss per Pulse Eoff 8530 Input Capacitance V_{CE} = 20 V, V_{GE} = 0 V, f = 1 MHz Cies 26093 _ pF _ **Output Capacitance** Coes 1012 _ _ **Reverse Transfer Capacitance** 104 Cres _ _ Total Gate Charge V_{CE} = 600 V, I_C = 300 A, Qg 1304 nC V_{GE} = 15 V Thermal Resistance -Thermal grease, R_{thJH} 0.207 K/W Chip-to-Heatsink Thickness = 2.1 Mil ±2% $\lambda = 2.9 \text{ W/mK}$ Thermal Resistance - Chip-to-Case R_{thJC} 0.087 K/W IGBT INVERSE DIODE (D1, D2, D3, D4) CHARACTERISTICS $I_F=150~A,~T_J=25^\circ C$ V Diode Forward Voltage V_{F} 2.0 2.6 I_F = 150 A, T_J = 150°C 1.77

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified) (continued)

Reverse Recovery Time	$T_{\rm J} = 25^{\circ} \rm C$	t _{rr}	-	105	-	ns
Reverse Recovery Charge	V _{CE} = 600 V, I _C = 150 A V _{GE} = -8 V, 15 V, R _G = 6 Ω	Q _{rr}	-	4179	_	nC
Peak Reverse Recovery Current		I _{RRM}	-	97	_	А
Peak Rate of Fall of Recovery Current		di/dt	-	4571	-	A/µs
Reverse Recovery Energy		E _{rr}	_	950	_	μJ
Reverse Recovery Time	$T_J = 125^{\circ}C$	t _{rr}	-	179	_	ns
Reverse Recovery Charge	V _{CE} = 600 V, I _C = 150 A V _{GE} = –8 V, 15 V, R _G = 6 Ω	Q _{rr}	-	11900	_	nC
Peak Reverse Recovery Current		I _{RRM}	_	132	_	А
Peak Rate of Fall of Recovery Current		di/dt	-	4167	-	A/μs
Reverse Recovery Energy]	E _{rr}	-	3750	_	μJ
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil ±2% λ = 2.9 W/mK	R _{thJH}	-	0.316	-	K/W
Thermal Resistance – Chip-to-Case		R _{thJC}	-	0.197	_	K/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified) (continued)

Characteristic	Test Conditions	Symbol	Min	Тур	Max	Unit	
THERMISTOR CHARACTERIST	HERMISTOR CHARACTERISTICS						
Nominal Resistance	T = 25°C	R ₂₅	-	22	-	kΩ	
Nominal Resistance	T = 100°C	R ₁₀₀	-	1486	-	Ω	
Deviation of R25		$\Delta R/R$	-5	-	5	%	
Power Dissipation		PD	-	200	-	mW	
Power Dissipation Constant			-	2	-	mW/K	
B-value	B (25/50), tolerance ±3%		-	3950	-	К	
B-value	B (25/100), tolerance $\pm 3\%$		-	3998	I	К	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ORDERING INFORMATION

Part Number	Marking	Package	Shipping
NXH400N100H4Q2F2PG PRESS FIT PINS	NXH400N100H4Q2F2PG	PIM42, 93x47 (PRESSFIT) (Pb-Free/Halide-Free)	12 Units / Blister Tray
NXH400N100H4Q2F2SG, NXH400N100H4Q2F2SG-R SOLDER PINS	NXH400N100H4Q2F2SG, NXH400N100H4Q2F2SG-R	PIM44, 93x47 (SOLDER PIN) (Pb-Free/Halide-Free)	12 Units / Blister Tray

TYPICAL CHARACTERISTICS – IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE

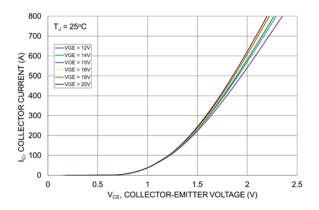


Figure 3. Typical Output Characteristics – Inner IGBT

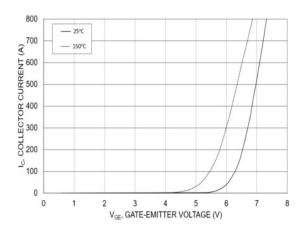


Figure 5. Transfer Characteristics – Inner IGBT

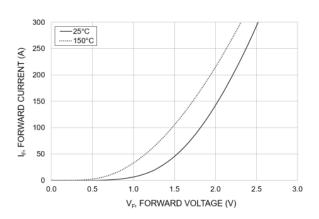


Figure 7. Inverse Diode Forward Characteristics

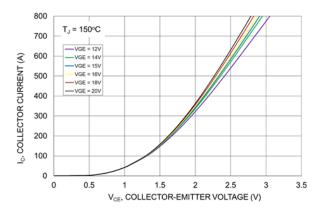


Figure 4. Typical Output Characteristics – Inner IGBT

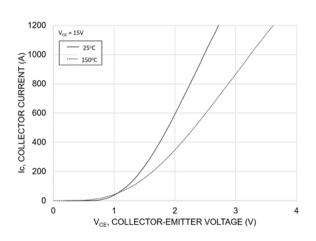


Figure 6. Saturation Voltage Characteristic

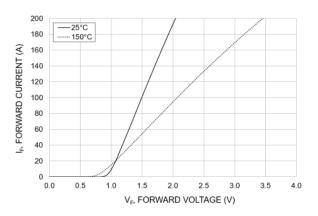


Figure 8. Buck Diode Forward Characteristics

10 $V_{GE} = +15V, -9V$ $V_{CE} = 600V$ $R_g = 6 \Omega$ 9 8 25°C 125°C 7 TURN ON LOSS (mJ) 6 5 4 ŝ з 2 1 0 0 50 100 150 200 250 300 Ic (A)



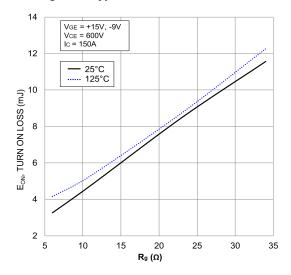


Figure 11. Typical Turn On Loss vs. R_a

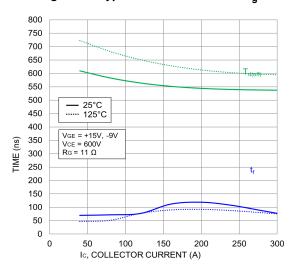


Figure 13. Typical Turn–Off Switching Time vs. IC

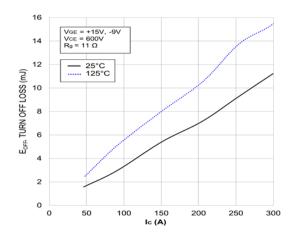


Figure 10. Typical Turn OFF Loss vs. IC

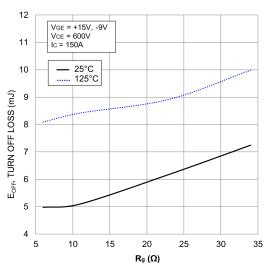


Figure 12. Typical Turn Off Loss vs. R_q

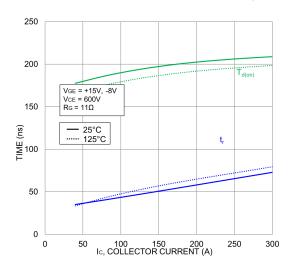
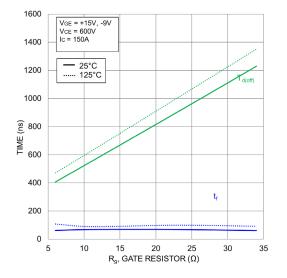


Figure 14. Typical Turn-On Switching Time vs. IC

TYPICAL CHARACTERISTICS – OUTER IGBT



TYPICAL CHARACTERISTICS – OUTER IGBT (CONTINUED)

Figure 15. Typical Turn-Off Switching Time vs. Rg

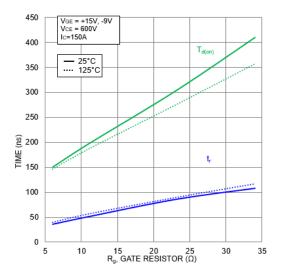


Figure 16. Typical Turn-On Switching Time vs. R_q

TYPICAL CHARACTERISTICS – INNER IGBT

16 $V_{GE} = +15V, -9V$ $V_{CE} = 600V$ $R_g = 6 \Omega$ 14 12 25°C ----- 125°C TURN ON LOSS (mJ) 10 8 6 н UN, 4 2 0 0 50 100 150 200 250 300 Ic (A)

Figure 17. Typical Turn On Switching Time vs. I_C

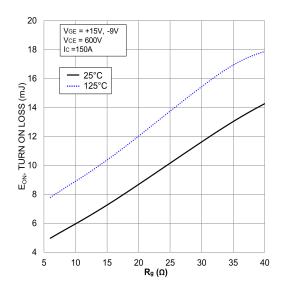


Figure 19. Typical Turn On Switching Time vs. R_G

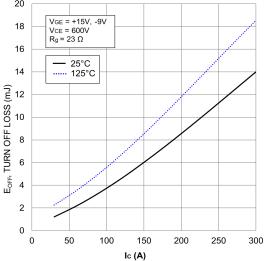


Figure 18. Typical Turn Off Switching Time vs. I_C

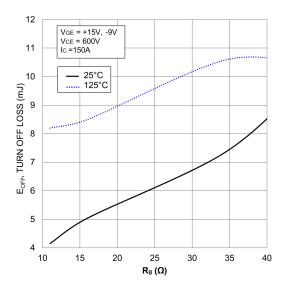


Figure 20. Typical Turn Off Switching Time vs. R_G

20

TYPICAL CHARACTERISTICS - INNER IGBT (CONTINUED)

800 700 T_{d(o} 600 VGE = +15V, -9V VCE = 600V RG = 11Ω 500 (su) 400 400 – 25°C ----- 25 C 300 200 100 t_f 0 0 50 100 150 200 250 300 Ic, COLLECTOR CURRENT (A)

Figure 23. Typical Turn-Off Switching Time vs. IC

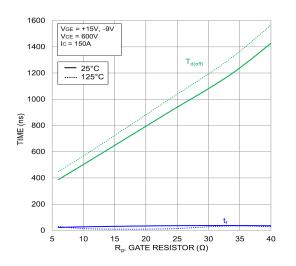


Figure 21. Typical Turn-Off Switching Time vs. Rg

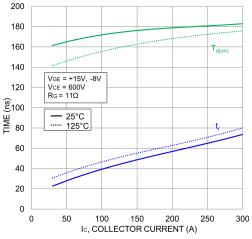


Figure 24. Typical Turn-On Switching Time vs. IC

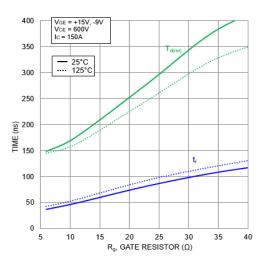


Figure 22. Typical Turn-On Switching Time vs.R_a

200

TYPICAL SWITCHING CHARACTERISTICS – NEUTRAL POINT DIODE

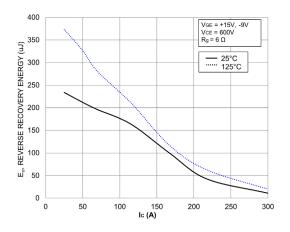


Figure 25. Typical Reverse Recovery Energy Loss vs. I_C

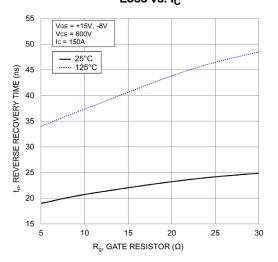


Figure 27. Typical Reverse Recovery Time vs. Rg

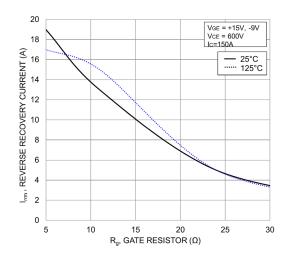


Figure 29. Typical Reverse Recovery Peak Current vs. R_g

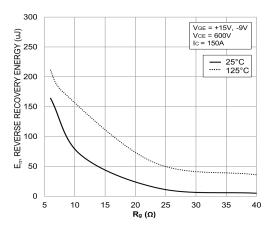


Figure 26. Typical Reverse Recovery Energy Loss vs. R_a

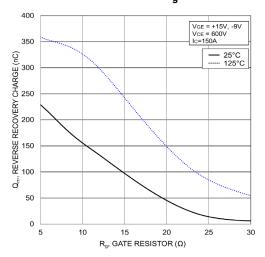


Figure 28. Typical Reverse Recovery Charge vs. R_a

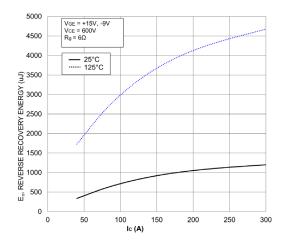


Figure 30. Typical Reverse Recovery Energy Loss vs. I_C

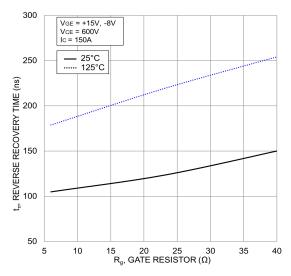


Figure 32. Typical Reverse Recovery Time vs. R_a

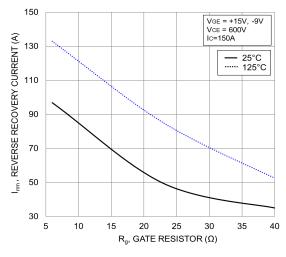


Figure 34. Typical Reverse Recovery Peak Current vs. R_g

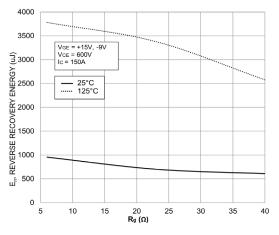


Figure 31. Typical Reverse Recovery Energy Loss vs. R_g

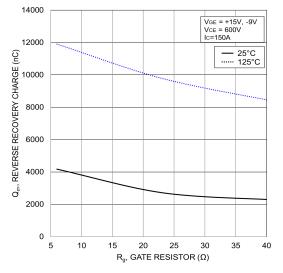


Figure 33. Typical Reverse Recovery Charge vs. R_q

TYPICAL CHARACTERISTICS – INVERSE DIODE

TYPICAL CHARACTERISTICS – IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE

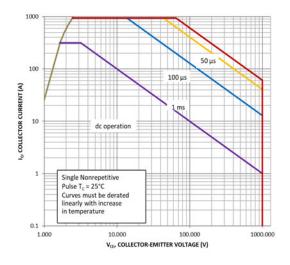


Figure 35. FBSOA – Outer IGBT

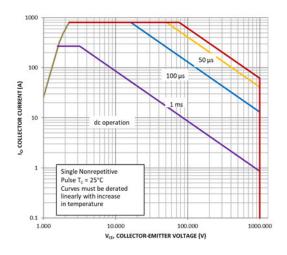


Figure 37. FBSOA – Inner IGBT

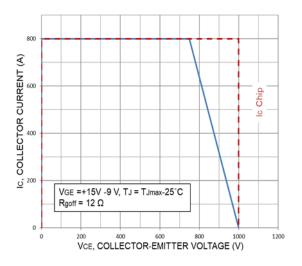


Figure 36. RBSOA – Outer IGBT

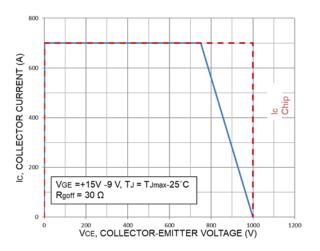
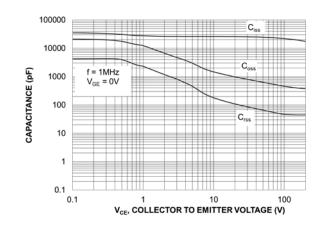


Figure 38. RBSOA – Inner IGBT



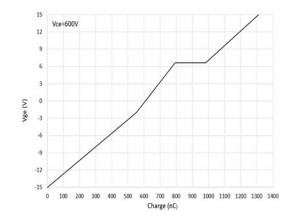




Figure 40. Capacitance Charge

TYPICAL CHARACTERISTICS - IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE (CONTINUED)

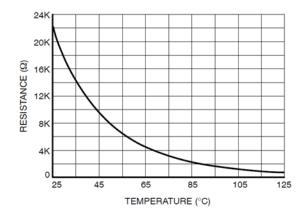


Figure 41. Thermistor Characteristics

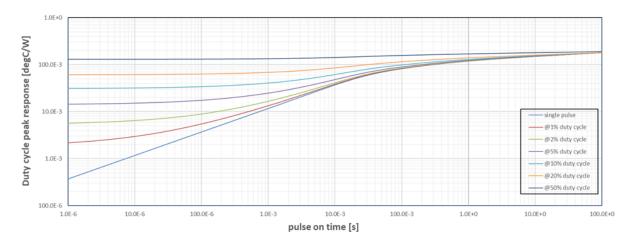


Figure 42. Transient Thermal Impedance – Outer IGBT

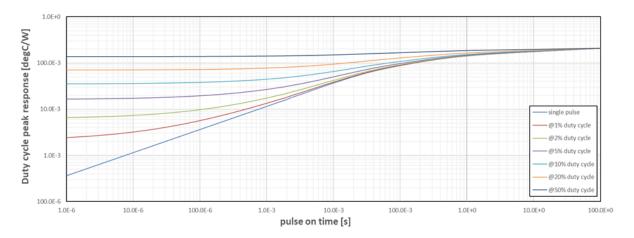
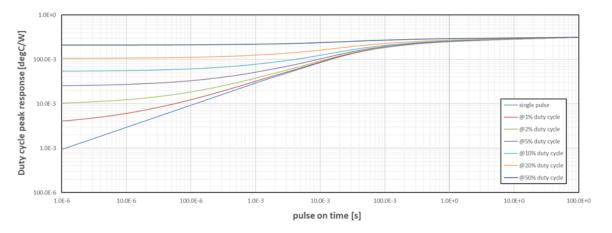


Figure 43. Transient Thermal Impedance – Inner IGBT

TYPICAL CHARACTERISTICS - IGBT, INVERSE DIODE AND NEUTRAL POINT DIODE (CONTINUED)





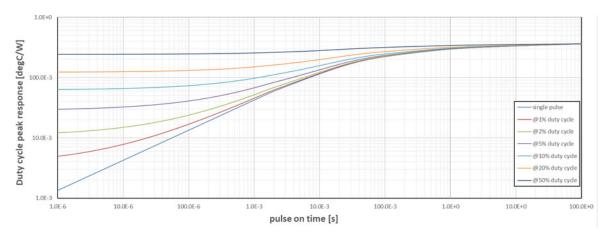
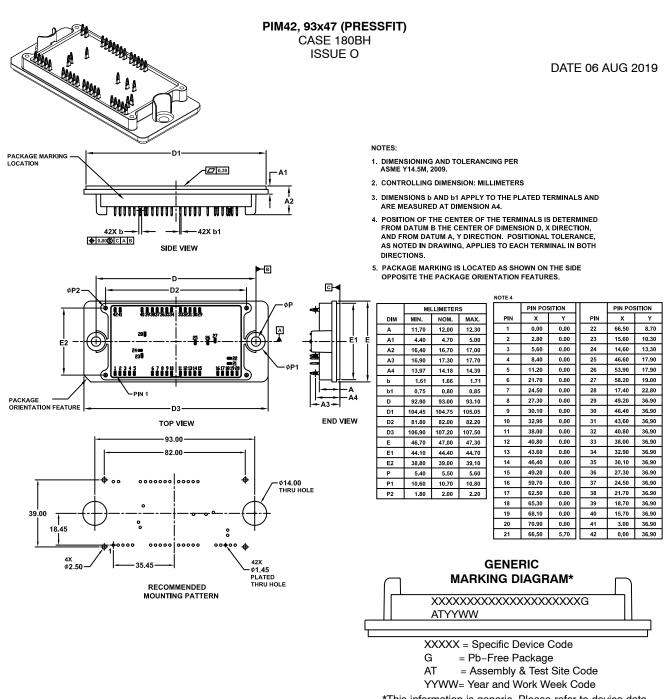


Figure 45. Transient Thermal Impedance – Neutral Point Diode

MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS





*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

 DOCUMENT NUMBER:
 98AON09951H
 Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.

 DESCRIPTION:
 PIM42 93X47 (PRESS FIT)
 PAGE 1 OF 1

 ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights nor the

MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS

ISSUE O DATE 03 DEC 2019 NOTES: PACKAGE MARKING 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009. LOCATION **D** 0.30 A1 2. CONTROLLING DIMENSION: MILLIMETERS 3. DIMENSIONS & AND & 1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A4 4. POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH 42X b DIRECTIONS 0.80**S** A B 5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE SIDE VIEW OPPOSITE THE PACKAGE ORIENTATION FEATURES. −В MULIMETERS DIM MIN. NOM. MAX. D2 ØP2 11.70 12.00 12.30 Α 4.40 4.70 5.00 A1 ö 4241 40 39 38 37 36 35 34 333231 3029 A2 16.40 16.70 17.00 А3 16.80 17.20 17.60 Α 28**0** b 0.95 1.00 1.05 26 27 **F1** E E2 + (+ D 92,90 93.00 93,10 24 O 230 D1 104.45 104.75 105.05 0 22 0 21 16 17 18 19 2 ØP1 D2 81.80 82.00 82.20 6 7 8 9 10 11 12 13 14 15 D3 107.20 107.50 106.90 Е 46.70 47.00 47.30 Α PIN 1 E1 44.10 44.40 44.70 A3 D3 F2 38.80 39.00 39.10 PACKAGE Р 5.40 5.50 5.60 END VIEW TOP VIEW **ORIENTATION FEATURE** P1 10.60 10.70 10.80 NOTE 4 P2 1.80 2.00 2.20 PIN POSITION PIN POSITION PIN х Y PIN х Y 1 0.00 0.00 22 66.50 8,70 2 2.80 0,00 23 15.60 10.30 3 5.60 0.00 24 14.60 13.30 8.40 0.00 25 46.60 17.90 4 11.20 0.00 26 53.90 17.90 5 21.70 27 6 0,00 58,20 19,00 7 24.50 0.00 28 17.40 22.80 GENERIC 8 27.30 0,00 29 49.20 36,90 **MARKING DIAGRAM*** 9 30.10 0.00 30 46.40 36.90 XXXXXXXXXXXXXXXXXXXXXXXXXXXX 10 32,90 0,00 31 43,60 36,90 ATYYWW 11 38.00 0.00 32 40.80 36,90 12 40.80 0.00 33 38.00 36.90 XXXXX = Specific Device Code 13 43.60 0.00 34 32.90 36.90 G = Pb-Free Package 14 46.40 0,00 35 30.10 36,90 = Assembly & Test Site Code 15 49.20 0.00 36 27.30 36.90 AT YYWW= Year and Work Week Code 16 59.70 37 24.50 36.90 0.00 17 62.50 0.00 38 36.90 21.70 *This information is generic. Please refer to device data 18 39 65.30 0.00 18.70 36.90 sheet for actual part marking. Pb-Free indicator, "G" or 19 68.10 0.00 40 15.70 36.90 microdot "•", may or may not be present. Some products may not follow the Generic Marking. 20 70.90 0.00 41 3.00 36.90 21 66.50 5.70 42 0.00 36.90 Electronic versions are uncontrolled except when accessed directly from the Document Repository. DOCUMENT NUMBER: 98AON15232H Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. **DESCRIPTION:** PIM42 93X47 (SOLDER PIN) PAGE 1 OF 1 ON Semiconductor and unarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding

the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the

PIM42, 93x47 (SOLDER PIN) CASE 180BS

© Semiconductor Components Industries, LLC, 2019

rights of others.



onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent_Marking.pdf</u>. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or indental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification. Buyer shall indemnify and hold onsemi and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs,

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

Technical Library: www.onsemi.com/design/resources/technical-documentation onsemi Website: www.onsemi.com

ONLINE SUPPORT: <u>www.onsemi.com/support</u> For additional information, please contact your local Sales Representative at <u>www.onsemi.com/support/sales</u>